**ON Semiconductor** 

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# Onsemi

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# <u>MOSFET</u> - Power, Dual N- & P-Channel, μ8FL

# 100 V, 70 mΩ, 9.5 A, -100 V, 186 mΩ, -5 A

# NTTBC070NP10M5L

#### Features

- Small Footprint (3 x 3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- $\bullet \ Low \ Q_G$  and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- Motor Drive, Home Automation

#### **MAXIMUM RATINGS** (T<sub>J</sub> = $25^{\circ}$ C, Unless otherwise specified)

| Par   | rameter                     |  | Symbol               | Q1     | Q2   | Unit |
|---|-----------------------------|--|----------------------|--------|------|------|
| Drain-to-Source Breakdown Voltage   |                             |  | V <sub>(BR)DSS</sub> | 100    | -100 | V    |
| Gate-to-Source \  | /oltage                     |  | V <sub>GS</sub>      | ±20    | ±20  | V    |
| Continuous<br>Drain Current<br>R <sub>θJC</sub> (Note 2)                                      | Steady<br>State             | T <sub>C</sub> = 25°C                    | Ι <sub>D</sub>       | 9.5    | -5   | A    |
| Power Dissipation $R_{\theta JC}$<br>(Note 2)   |                             |  | P <sub>D</sub>       | 14     | 10   | W    |
| Continuous<br>Drain Current<br>R <sub>θJA</sub> (Note 1, 2)                                   | Steady<br>State             | T <sub>A</sub> = 25°C                    | Ι <sub>D</sub>       | 3.5    | -2.2 | A    |
| Power Dissipation R <sub>0JA</sub><br>(Note 1, 2)   |                             |  | P <sub>D</sub>       | 1.9    | 1.9  | W    |
| Pulsed Drain<br>Current   | $T_{A} = 25^{\circ}C$       | $T_A = 25^{\circ}C$ , $t_p = 10 \ \mu s$ |                      | 33     | 33   | A    |
| Operating Junctio<br>perature Range   | n and Stor                  | age Tem-                                 | TJ, T <sub>stg</sub> | –55 to | +150 | °C   |
| Source Current (E   | Source Current (Body Diode) |  |                      | 12     | 8    | А    |
| Single Pulse Drain-to-Source<br>Avalanche Energy<br>(I <sub>L</sub> = 7.3 A, 7.8 A, L = 1 mH) |                             |  | E <sub>AS</sub>      | 26     | 30   | mJ   |
| Lead Temperature<br>Soldering Purpose<br>(1/8" from case fo                                   | es                          | Reflow for                               | TL                   | 260    | 260  | °C   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 in<sup>2</sup> pad size, 1 oz Cu pad.

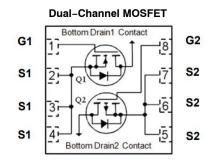
The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

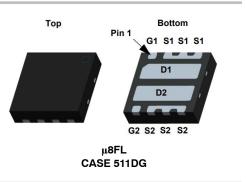


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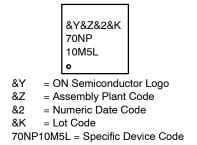
#### www.onsemi.com

| V <sub>(BR)DSS</sub> | R <sub>DS(ON)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| 100 V                | 70 mΩ @ 10 V            | 9.5 A              |
| –100 V               | 186 m $\Omega$ @ 10 V   | –5 A               |





#### MARKING DIAGRAM



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 10 of this data sheet.

#### THERMAL CHARACTERISTICS

| Symbol              | Parameter                                   | Q1  | Q2   | Unit |
|---------------------|---|-----|------|------|
| $R_{	ext{	heta}JC}$ | Junction-to-Case - Steady State (Note 3)    | 8.9 | 12.5 | °C/W |
| $R_{	hetaJA}$       | Junction-to-Ambient – Steady State (Note 3) | 65  | 65   |      |

3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

#### **ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL)** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

| Parameter  | Symbol  | Test Condition   | าร                        | Min | Тур  | Max  | Unit  |
|--|---|--|---------------------------|-----|------|------|-------|
| OFF CHARACTERISTICS  | -   |  |                           |     | -    | -    | -     |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                            | $V_{GS} = 0 V, I_D = 25$                                 | 50 μΑ                     | 100 |      |      | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> / T <sub>J</sub>           | $I_D = 250 \ \mu\text{A}$ , ref to $25^{\circ}\text{C}$  |                           |     | 70   |      | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                                | $V_{GS} = 0 V,$ $T_{J} = 25^{\circ}C$                    |                           |     |      | 1    | μΑ    |
|  |   | V <sub>GS</sub> = 0 V,<br>V <sub>DS</sub> = 100 V        | T <sub>J</sub> = 125°C    |     |      | 100  |       |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                                | V <sub>DS</sub> = 0 V, V <sub>GS</sub> = =               | ±20 V                     |     |      | ±100 | nA    |
| ON CHARACTERISTICS   |   |  |                           |     |      |      |       |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                             | $V_{GS} = V_{DS}, I_D = 2$                               | 4 μ <b>A</b>              | 1.0 |      | 3.0  | V     |
| Negative Threshold Temperature<br>Coefficient                | V <sub>GS(TH)</sub> <sup>/</sup> T <sub>J</sub> | $I_D = 24 \ \mu A$ , ref to 2                            | 25°C                      |     | 7.1  |      | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                             | $V_{GS} = 10 \text{ V}, \text{ I}_{D} = 10 \text{ V}$    | 1.3A                      |     | 47   | 70   | mΩ    |
|  |   | $V_{GS}$ = 4.5 V, I <sub>D</sub> =                       | 1.0 A                     |     | 67   | 102  | 1     |
| Forward Transconductance                                     | 9 <sub>FS</sub>                                 | $V_{DS} = 5 V, I_D = 4 A$                                |                           |     | 6.2  |      | S     |
| Gate-Resistance  | R <sub>G</sub>                                  | T <sub>A</sub> = 25°C                                    |                           |     | 0.74 |      | Ω     |
| CHARGES & CAPACITANCES                                       | •   |  |                           |     |      |      | •     |
| Input Capacitance  | C <sub>ISS</sub>                                | V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 50 V |                           |     | 252  |      | pF    |
| Output Capacitance   | C <sub>OSS</sub>                                |  |                           |     | 64   |      | 7     |
| Reverse Transfer Capacitance                                 | C <sub>RSS</sub>                                |  |                           |     | 3    |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                             |  |                           |     | 3    |      | nC    |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                              |  |                           |     | 0.6  |      |       |
| Gate-to-Source Charge  | Q <sub>GS</sub>                                 | $V_{GS}$ = 4.5 V, $V_{DS}$ = 50 V                        | ν, I <sub>D</sub> = 1.3 A |     | 1.0  |      | 1     |
| Gate-to-Drain Charge   | Q <sub>GD</sub>                                 |  |                           |     | 1.1  |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                             |  |                           |     | 5.6  |      |       |
| Plateau Voltage  | V <sub>GP</sub>                                 | V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 50 V           | , I <sub>D</sub> = 1.3 A  |     | 2.6  |      | V     |
| SWITCHING CHARACTERISTICS                                    |   |  |                           |     |      |      |       |
| Turn-On Delay Time   | t <sub>d(ON)</sub>                              |  |                           |     | 5.3  |      | ns    |
| Rise Time  | t <sub>r</sub>                                  | V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 50 V           | , I <sub>D</sub> = 1.3 A. |     | 2.5  |      | 1     |
| Turn-Off Delay Time  | t <sub>d(OFF)</sub>                             | $R_{\rm G} = 6 \Omega$                                   |                           |     | 12.4 |      |       |
| Fall Time  | t <sub>f</sub>                                  |  |                           |     | 7.5  |      | 1     |
| Turn-On Delay Time   | t <sub>d(ON)</sub>                              |  |                           |     | 7.6  |      | ns    |
| Rise Time  | t <sub>r</sub>                                  | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 50 V          | , I <sub>D</sub> = 1.3 A. |     | 7.6  |      |       |
| Turn-Off Delay Time  | t <sub>d(OFF)</sub>                             | $R_{\rm G} = 6 \Omega$                                   | , u,                      |     | 10.4 |      | 1     |
| Fall Time  | t <sub>f</sub>                                  |  |                           |     | 9    |      | 1     |

#### ELECTRICAL CHARACTERISTICS (Q1, N-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

| Parameter | Symbol | Test Conditions | Min | Тур | Max | Unit |
|-----------|--------|-----------------|-----|-----|-----|------|
|           |        |                 |     |     |     |      |

| OFF CHARACTERISTICS     |                 |  |                        |      |     |    |
|-------------------------|-----------------|--|------------------------|------|-----|----|
| Forward Diode Voltage   | V <sub>SD</sub> | $V_{GS} = 0 V_{c}$   | $T_J = 25^{\circ}C$    | 0.75 | 1.2 | V  |
|                         |                 | V <sub>GS</sub> = 0 V,<br>I <sub>S</sub> = 1.3 A                         | T <sub>J</sub> = 125°C | 0.6  |     |    |
| Reverse Recovery Time   | t <sub>RR</sub> |  | ·                      | 28   |     | ns |
| Charge Time             | t <sub>a</sub>  | V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt =                             | 13                     |      |     |    |
| Discharge Time          | t <sub>b</sub>  | $V_{GS}$ = 0 V, dI <sub>S</sub> /dt = 50 A/µs,<br>I <sub>S</sub> = 1.2 A |                        | 15   |     |    |
| Reverse Recovery Charge | Q <sub>RR</sub> |  |                        | 8    |     | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

#### ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted)

| Parameter  | Symbol  | Test Conditions  |  | Min  | Тур  | Max  | Unit  |
|--|---|--|--|------|------|------|-------|
| OFF CHARACTERISTICS  |   |  |  |      |      |      |       |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                            | $V_{GS}$ = 0 V, $I_D$ = -250 $\mu$ A                                       |  | -100 |      |      | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> / T <sub>J</sub>           | I <sub>D</sub> = –250 μA, ref tc   | $I_D = -250 \ \mu\text{A}$ , ref to $25^{\circ}\text{C}$ |      | 60   |      | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                                | V 0.V.V 400.V  | $T_J = 25^{\circ}C$                                      |      |      | -1   | μA    |
|  |   | $V_{GS} = 0 V, V_{DS} = -100 V$  | T <sub>J</sub> = 125°C                                   |      |      | -100 |       |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                                | $V_{DS}$ = 0 V, $V_{GS}$ = ±20 V   |  |      |      | ±100 | nA    |
| ON CHARACTERISTICS   |   |  |  |      |      |      |       |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                             | $V_{GS} = V_{DS}, I_D = -4$  | 40 μA  | -2.0 |      | -4.0 | V     |
| Negative Threshold Temperature<br>Coefficient                | V <sub>GS(TH)</sub> <sup>/</sup> T <sub>J</sub> | $I_D = -40 \ \mu A$ , ref to   | 25°C   |      | 6.6  |      | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                             | V <sub>GS</sub> = -10 V, I <sub>D</sub> = -                                | -2.2 A   |      | 146  | 186  | mΩ    |
|  |   | $V_{GS} = -6 \text{ V}, \text{ I}_{D} = -1.4 \text{ A}$                    |  |      | 178  | 284  |       |
| Forward Transconductance                                     | 9 <sub>FS</sub>                                 | $V_{DS} = 5 \text{ V}, \text{ I}_{D} = -4 \text{ A}$                       |  |      | 5.9  |      | S     |
| Gate-Resistance  | R <sub>G</sub>                                  | $T_A = 25^{\circ}C$  |  |      | 1.75 |      | Ω     |
| CHARGES & CAPACITANCES                                       |   |  |  |      |      |      |       |
| Input Capacitance  | C <sub>ISS</sub>                                |  |  |      | 256  |      | pF    |
| Output Capacitance   | C <sub>OSS</sub>                                | V <sub>GS</sub> = 0 V, f = 1 MHz, V  | <sub>DS</sub> = -50 V                                    |      | 63   |      |       |
| Reverse Transfer Capacitance                                 | C <sub>RSS</sub>                                |  |  |      | 3    |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                             |  |  |      | 7.3  |      | nC    |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                              |  |  |      | 1.5  |      |       |
| Gate-to-Source Charge  | Q <sub>GS</sub>                                 | V <sub>GS</sub> = -10 V, V <sub>DS</sub> = -50 \                           | /, I <sub>D</sub> = –2.2 A                               |      | 2.4  |      |       |
| Gate-to-Drain Charge   | Q <sub>GD</sub>                                 |  |  |      | 1.2  |      |       |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                             |  |  |      | 4.6  |      | nC    |
| Plateau Voltage  | V <sub>GP</sub>                                 | $V_{GS} = -6$ V, $V_{DD} = -50$ V, $I_{D} = -2.2$ A                        |  |      | 4.5  |      | V     |
| SWITCHING CHARACTERISTICS                                    |   |  |  |      |      |      |       |
| Turn-On Delay Time   | t <sub>d(ON)</sub>                              |  |  |      | 8.9  |      | ns    |
| Rise Time  | t <sub>r</sub>                                  | $V_{GS}$ = -10 V, $V_{DS}$ = -50 V, $I_{D}$ = -2.2 A, $R_{G}$ = 6 $\Omega$ |  |      | 3.6  |      |       |
| Turn-Off Delay Time  | t <sub>d(OFF)</sub>                             | $R_{G} = 6 \Omega$   | , <b>D</b> ,   |      | 13.2 |      |       |
| Fall Time  | t <sub>f</sub>                                  | 1  |  |      | 3.4  |      |       |

#### ELECTRICAL CHARACTERISTICS (Q2, P-CHANNEL) (T<sub>J</sub> = 25°C unless otherwise noted) (continued)

ta

t<sub>b</sub>

 $\mathsf{Q}_{\mathsf{R}\mathsf{R}}$ 

Charge Time

Discharge Time

Reverse Recovery Charge

| Parameter             | Symbol              | Test Conditions  |  | Min | Тур   | Max  | Unit |
|-----------------------|---------------------|--|--|-----|-------|------|------|
| Turn-On Delay Time    | t <sub>d(ON)</sub>  | $V_{GS}$ = –6 V, $V_{DS}$ = –50 V, $I_{D}$ = –2.2 A, $R_{G}$ = 6 $\Omega$        |  |     | 10.8  |      | ns   |
| Rise Time             | t <sub>r</sub>      |  |  |     | 4.8   |      |      |
| Turn-Off Delay Time   | t <sub>d(OFF)</sub> |  |  |     | 10    |      |      |
| Fall Time             | t <sub>f</sub>      |  |  |     | 4.1   |      |      |
| OFF CHARACTERISTICS   |                     |  |  |     |       |      |      |
| Forward Diode Voltage | V <sub>SD</sub>     | $V_{GS} = 0 V, \\ I_{S} = -2.2 A \\ T_{J} = 25^{\circ}C \\ T_{J} = 125^{\circ}C$ |  |     | -0.86 | -1.2 | V    |
|                       |                     |  |  |     | -0.72 |      |      |
| Reverse Recovery Time | t <sub>RR</sub>     |  |  |     | 34    |      | ns   |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

 $\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \, dI_S/dt = 100 \ \text{A}/\mu\text{s}, \\ I_S = -1.1 \ \text{A} \end{array}$ 

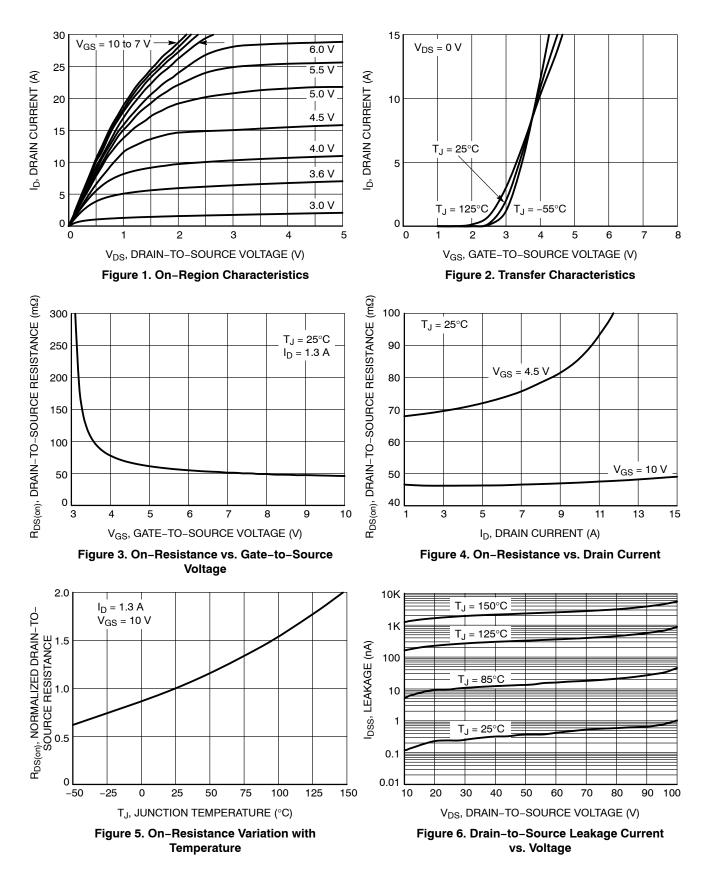
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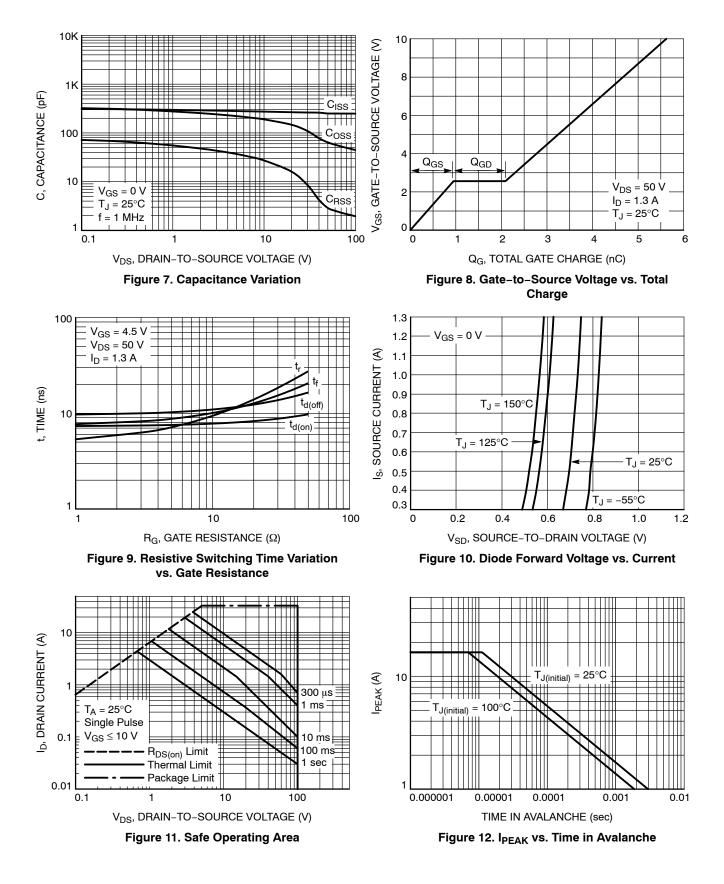
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nC

#### **TYPICAL CHARACTERISTICS – N-CHANNEL**



#### **TYPICAL CHARACTERISTICS – N-CHANNEL**



#### **TYPICAL CHARACTERISTICS – N-CHANNEL**

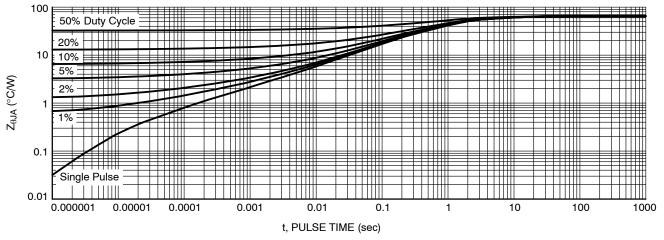
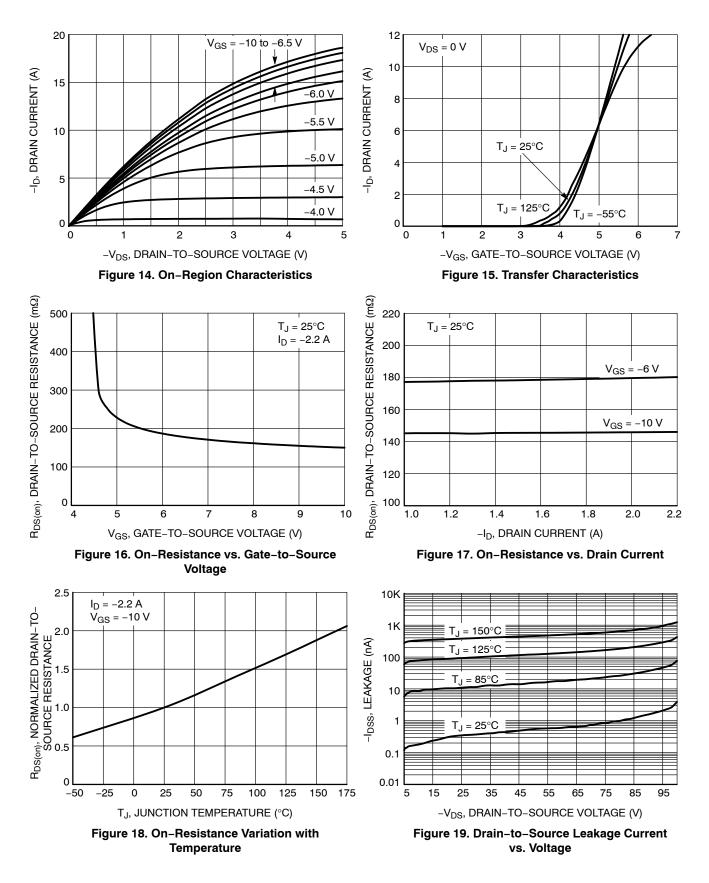
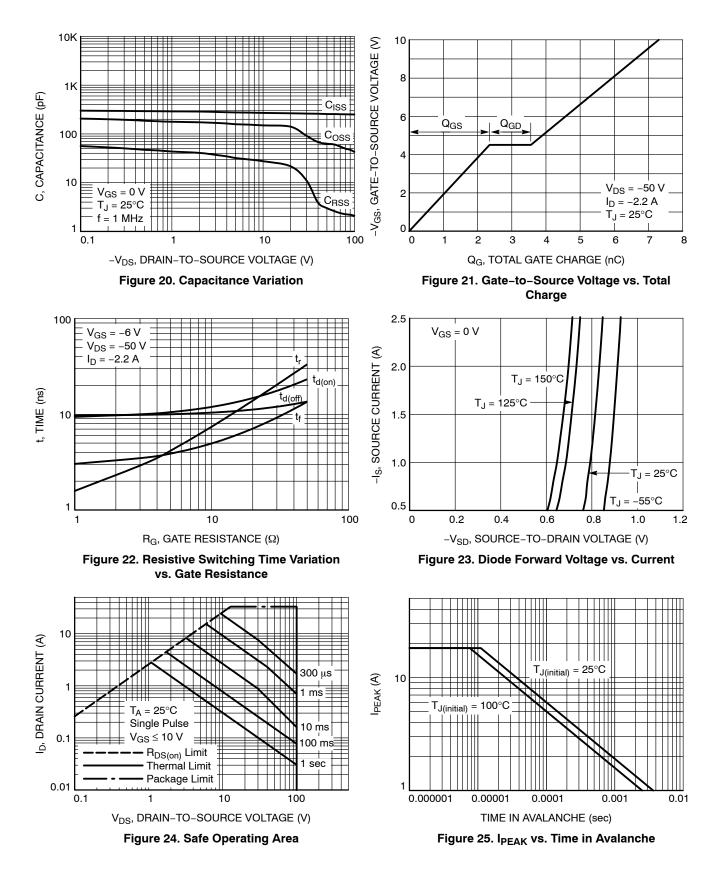


Figure 13. Junction-to-Ambient Transient Thermal Response

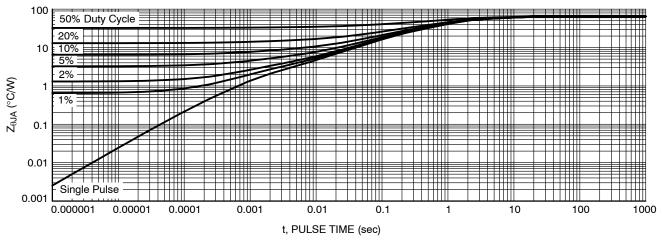
#### **TYPICAL CHARACTERISTICS – P-CHANNEL**



#### **TYPICAL CHARACTERISTICS – P-CHANNEL**



#### **TYPICAL CHARACTERISTICS – P-CHANNEL**



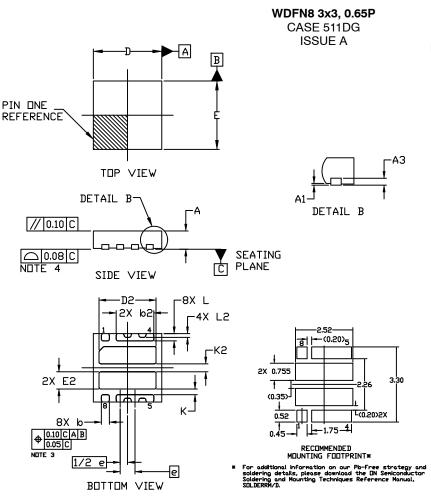


#### **ORDERING INFORMATION**

| Device          | Device Marking | Package                        | Shipping (Qty / Packing) $^{\dagger}$ |
|-----------------|----------------|--------------------------------|---------------------------------------|
| NTTBC070NP10M5L | 70NP10M5L      | μ8FL<br>(Pb–Free/Halogen Free) | 3000 / Tape & Reel                    |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



NDTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSION & APPLIES TO PLATED TERMINALS AND IS MEASURED BETWEEN 0.15 AND 0.30MM FROM THE TERMINAL TIP.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

|     | MI       | MILLIMETERS |      |  |  |  |
|-----|----------|-------------|------|--|--|--|
| DIM | MIN.     | NDM.        | MAX. |  |  |  |
| A   | 0.70     | 0.75        | 0.80 |  |  |  |
| A1  | 0.00     |             | 0.05 |  |  |  |
| A3  | -        | 0.20 REF    | -    |  |  |  |
| b   | 0.30     | 0.35        | 0.40 |  |  |  |
| b2  | 1.65 REF |             |      |  |  |  |
| D   | 2.90     | 3.00        | 3.10 |  |  |  |
| DS  | 2.45     | 2.50        | 2.55 |  |  |  |
| E   | 2.90     | 3.00        | 3.10 |  |  |  |
| E5  | 1.40     | 1.50        | 1.60 |  |  |  |
| e   |          | 0.65 BSC    |      |  |  |  |
| к   | 0.25     |             |      |  |  |  |
| K5  | 0.35 REF |             |      |  |  |  |
| L   | 0.27     | 0.32        | 0.37 |  |  |  |
| L2  | (        | ).163 REF   | -    |  |  |  |

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